



IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L JQAJP 13.0001-03

CB Certificate No.: JQAQ0001-004-T

Schedule Number: IECQ-L JQAJP 13.0001-03-S Rev No.: 4 Revision Date: 2016/10/14 Page 1 of 1

Type of Components

IEC 60384-1:2008 Fixed capacitor
IEC 60115-1:2008 Fixed resistor
IEC 62326-1:2002 Printed circuit board

ENVIRONMENTAL TEST

IEC 60068-2-1:2007 Cold
IEC 60068-2-2:2007 Dry heat
IEC 60068-2-14:2012 Change of temperature
IEC 60068-2-30:2005 Damp heat, cyclic (12+12-hour cycle)
IEC 60068-2-38:2009 Composite temperature/humidity cyclic test
IEC 60068-2-66:1994 Damp heat, steady state (unsaturated pressurized vapour)
IEC 60068-2-78:2012 Damp heat, steady state

MECHANICAL TEST

IEC 60068-2-6:2007 Vibration (sinusoidal)

This schedule is only valid in conjunction with the referenced Certificate of Approval

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